74AC00, 74ACT00 — Quad 2-Input NAND Gate



74AC00, 74ACT00 Quad 2-Input NAND Gate

Features

- I_{CC} reduced by 50%
- Outputs source/sink 24mA
- ACT00 has TTL-compatible inputs

General Description

The AC00/ACT00 contains four, 2-input NAND gates.

| Order Number | Package Number | Package Description |
|-----------------|-------------------|--|
| 74AC00SC | M14A | 14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow |
| 74AC00SJ | M14D | 14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide |
| 74AC00MTC | MTC14 | 14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide |
| 74AC00PC | N14A | 14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide |
| 74ACT00SC | M14A | 14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow |
| 74ACT00SJ | M14D | 14-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide |
| 74ACT00MTC | MTC14 | 14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide |
| 74ACT00PC | N14A | 14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide |

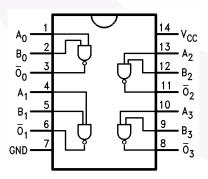
Ordering Information

Device also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering number.

All packages are lead free per JEDEC: J-STD-020B standard.

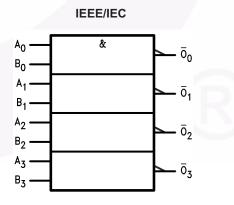
Connection Diagram

Logic Symbol



Pin Description

| Pin Names | Description |
|---------------------------------|-------------|
| A _n , B _n | Inputs |
| Ō _n | Outputs |



Absolute Maximum Ratings

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only.

| Symbol | Parameter | Rating |
|-------------------------------------|---|---------------------------------|
| V _{CC} | Supply Voltage | -0.5V to +7.0V |
| I _{IK} | DC Input Diode Current | |
| | $V_{I} = -0.5V$ | –20mA |
| | V _I = V _{CC} + 0.5 | +20mA |
| VI | DC Input Voltage | -0.5V to V _{CC} + 0.5V |
| I _{ОК} | DC Output Diode Current | |
| | $V_{O} = -0.5V$ | –20mA |
| | $V_{\rm O} = V_{\rm CC} + 0.5 V$ | +20mA |
| Vo | DC Output Voltage | -0.5V to V _{CC} + 0.5V |
| Ι _Ο | DC Output Source or Sink Current | ±50mA |
| I _{CC} or I _{GND} | DC V _{CC} or Ground Current per Output Pin | ±50mA |
| T _{STG} | Storage Temperature | –65°C to +150°C |
| TJ | Junction Temperature | 140°C |

Recommended Operating Conditions

The Recommended Operating Conditions table defines the conditions for actual device operation. Recommended operating conditions are specified to ensure optimal performance to the datasheet specifications. Fairchild does not recommend exceeding them or designing to absolute maximum ratings.

| Symbol | Parameter | Rating |
|-----------------------|---|-----------------------|
| V _{CC} | Supply Voltage | |
| | AC | 2.0V to 6.0V |
| | ACT | 4.5V to 5.5V |
| VI | Input Voltage | 0V to V _{CC} |
| Vo | Output Voltage | 0V to V _{CC} |
| T _A | Operating Temperature | -40°C to +85°C |
| $\Delta V / \Delta t$ | Minimum Input Edge Rate, AC Devices: | 125mV/ns |
| | $V_{\rm IN}$ from 30% to 70% of $V_{\rm CC}, V_{\rm CC}$ @ 3.3V, 4.5V, 5.5V | |
| $\Delta V / \Delta t$ | Minimum Input Edge Rate, ACT Devices: | 125mV/ns |
| | V _{IN} from 0.8V to 2.0V, V _{CC} @ 4.5V, 5.5V | |

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DC Electrical Characteristics for AC

| | | V _{cc} | | $T_A = 1$ | ⊦25°C | $T_{A} = -40^{\circ}C \text{ to } +85^{\circ}C$ | |
|--------------------------------|-------------------------------------|-----------------|---|-----------|-------|---|-------|
| Symbol | Parameter | (V) | Conditions | Тур. | G | uaranteed Limits | Units |
| V _{IH} | Minimum HIGH Level | 3.0 | $V_{OUT} = 0.1V$ | 1.5 | 2.1 | 2.1 | V |
| | Input Voltage | 4.5 | or V _{CC} – 0.1V | 2.25 | 3.15 | 3.15 | 1 |
| | | 5.5 | | 2.75 | 3.85 | 3.85 | 1 |
| V _{IL} | Maximum LOW Level | 3.0 | $V_{OUT} = 0.1V$ | 1.5 | 0.9 | 0.9 | V |
| | Input Voltage | 4.5 | or V _{CC} – 0.1V | 2.25 | 1.35 | 1.35 | 1 |
| | | 5.5 | - | 2.75 | 1.65 | 1.65 | 1 |
| V _{OH} | Minimum HIGH Level | 3.0 | Ι _{ΟUT} = –50μΑ | 2.99 | 2.9 | 2.9 | V |
| | Output Voltage | 4.5 | | 4.49 | 4.4 | 4.4 | 1 |
| | | 5.5 | | 5.49 | 5.4 | 5.4 | 1 |
| | | 3.0 | $V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OH} = -12 \text{mA}$ | | 2.56 | 2.46 | |
| | | 4.5 | $V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OH} = -24 \text{mA}$ | | 3.86 | 3.76 | - |
| | | 5.5 | $V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OH} = -24 \text{mA}^{(1)}$ | | 4.86 | 4.76 | |
| V _{OL} | Maximum LOW Level | 3.0 | Ι _{ΟUT} = 50μΑ | 0.002 | 0.1 | 0.1 | V |
| | Output Voltage | 4.5 | - | 0.001 | 0.1 | 0.1 | 1 |
| | | 5.5 | | 0.001 | 0.1 | 0.1 | 1 |
| | | 3.0 | $V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OL} = 12 \text{mA}$ | | 0.36 | 0.44 | |
| | | 4.5 | $V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OL} = 24 \text{mA}$ | | 0.36 | 0.44 | |
| | | 5.5 | $V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OL} = 24 \text{mA}^{(1)}$ | | 0.36 | 0.44 | |
| I _{IN} ⁽³⁾ | Maximum Input Leakage Current | 5.5 | $V_{I} = V_{CC}$, GND | | ±0.1 | ±1.0 | μA |
| I _{OLD} | Minimum Dynamic | 5.5 | V _{OLD} = 1.65V Max. | | | 75 | mA |
| I _{OHD} | Output Current ⁽²⁾ | 5.5 | V _{OHD} = 3.85V Min. | | | -75 | mA |
| I _{CC} ⁽³⁾ | Maximum Quiescent Supply Current | 5.5 | $V_{IN} = V_{CC}$ or GND | | 2.0 | 20.0 | μA |

Notes:

1. All outputs loaded; thresholds on input associated with output under test.

2. Maximum test duration 2.0ms, one output loaded at a time.

3. $I_{\rm IN}$ and $I_{\rm CC}$ @ 3.0V are guaranteed to be less than or equal to the respective limit @ 5.5V $V_{\rm CC}.$

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DC Electrical Characteristics for ACT

| | | V _{cc} | | $T_A = H$ | -25°C | T _A = -40°C to +85°C | |
|------------------|-------------------------------------|-----------------|---|-----------|-------|---------------------------------|-------|
| Symbol | Parameter | (V) | Conditions | Тур. | G | Juaranteed Limits | Units |
| V _{IH} | Minimum HIGH Level | 4.5 | $V_{OUT} = 0.1V$ or | 1.5 | 2.0 | 2.0 | V |
| | Input Voltage | | V _{CC} – 0.1V | 1.5 | 2.0 | 2.0 | 1 |
| V _{IL} | Maximum LOW Level | 4.5 | $V_{OUT} = 0.1V$ or | 1.5 | 0.8 | 0.8 | V |
| | Input Voltage | 5.5 | V _{CC} – 0.1V | 1.5 | 0.8 | 0.8 | 1 |
| V _{OH} | Minimum HIGH Level | 4.5 | $I_{OUT} = -50 \mu A$ | 4.49 | 4.4 | 4.4 | V |
| | Output Voltage | 5.5 | - | 5.49 | 5.4 | 5.4 | 1 |
| | | 4.5 | $V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OH} = -24 \text{mA}$ | | 3.86 | 3.76 | |
| | | 5.5 | $V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OH} = -24 \text{mA}^{(4)}$ | | 4.86 | 4.76 | |
| V _{OL} | Maximum LOW Level | 4.5 | $I_{OUT} = 50 \mu A$ | 0.001 | 0.1 | 0.1 | V |
| | Output Voltage | 5.5 | - | 0.001 | 0.1 | 0.1 |] |
| | | 4.5 | $V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OL} = 24 \text{mA}$ | | 0.36 | 0.44 | |
| | | 5.5 | $V_{IN} = V_{IL} \text{ or } V_{IH},$ $I_{OL} = 24 \text{mA}^{(4)}$ | | 0.36 | 0.44 | |
| I _{IN} | Maximum Input Leakage Current | 5.5 | $V_I = V_{CC}$, GND | | ±0.1 | ±1.0 | μA |
| I _{CCT} | Maximum I _{CC} /Input | 5.5 | $V_{I} = V_{CC} - 2.1V$ | 0.6 | | 1.5 | mA |
| I _{OLD} | Minimum Dynamic | 5.5 | V _{OLD} = 1.65V Max. | | | 75 | mA |
| I _{OHD} | Output Current ⁽⁵⁾ 5.5 | | V _{OHD} = 3.85V Min. | | | -75 | mA |
| I _{CC} | Maximum Quiescent Supply Current | 5.5 | $V_{IN} = V_{CC}$ or GND | | 2.0 | 20.0 | μA |

Notes:

4. All outputs loaded; thresholds on input associated with output under test.

5. Maximum test duration 2.0ms, one output loaded at a time.

AC Electrical Characteristics for AC

| | | | T _A C | _ = +25° ⊢_ = 50p | Ċ, F | $\begin{vmatrix} T_{A} = -40^{\circ}C \\ C_{L} = \end{vmatrix}$ | c to +85°C, 50pF | |
|------------------|-------------------|------------------------------------|---------------------|----------------------|---------|---|---------------------|-------|
| Symbol | Parameter | V _{CC} (V) ⁽⁶⁾ | Min. | Тур. | Max. | Min. | Max. | Units |
| t _{PLH} | Propagation Delay | 3.3 | 2.0 | 7.0 | 9.5 | 2.0 | 10.0 | ns |
| | | 5.0 | 1.5 | 6.0 | 8.0 | 1.5 | 8.5 | |
| t _{PHL} | Propagation Delay | 3.3 | 1.5 | 5.5 | 8.0 | 1.0 | 8.5 | ns |
| | | 5.0 | 1.5 | 4.5 | 6.5 | 1.0 | 7.0 | |

Note:

6. Voltage range 3.3 is 3.3V \pm 0.3V. Voltage range 5.0 is 5.0V \pm 0.5V.

AC Electrical Characteristics for ACT

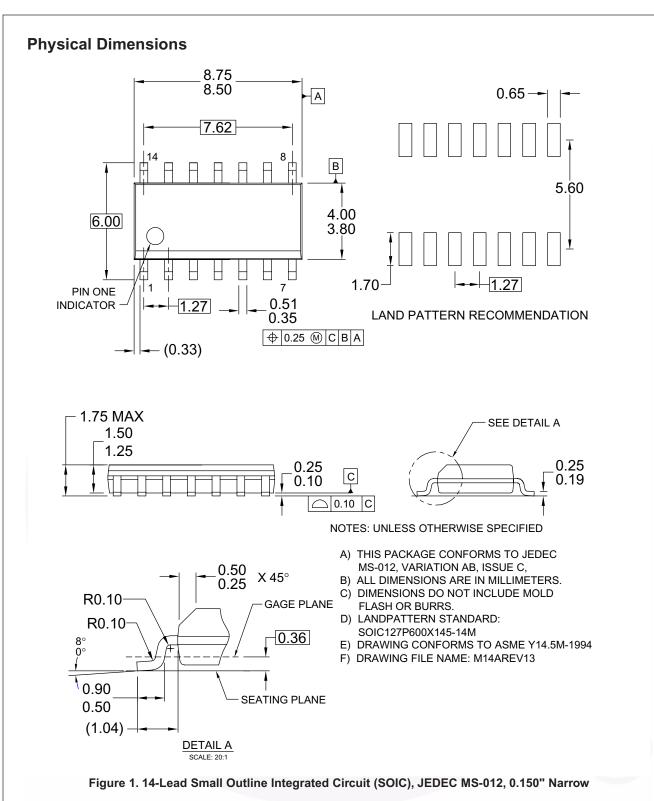
| | | | | λ = +25° 3 _L = 50p | | $T_A = -40^{\circ}C$ $C_L =$ | to +85°C, 50pF | |
|------------------|-------------------|------------------------------------|------|----------------------------------|------|---------------------------------|-------------------|-------|
| Symbol | Parameter | V _{CC} (V) ⁽⁷⁾ | Min. | Тур. | Max. | Min. | Max. | Units |
| t _{PLH} | Propagation Delay | 5.0 | 1.5 | 5.5 | 9.0 | 1.0 | 9.5 | ns |
| t _{PHL} | Propagation Delay | 5.0 | 1.5 | 4.0 | 7.0 | 1.0 | 8.0 | ns |

Note:

7. Voltage Range 5.0 is $5.0V \pm 0.5V$.

Capacitance

| Symbol | Parameter | Conditions | Тур. | Units |
|-----------------|-------------------------------|------------------------|------|-------|
| C _{IN} | Input Capacitance | V _{CC} = OPEN | 4.5 | pF |
| C _{PD} | Power Dissipation Capacitance | $V_{CC} = 5.0V$ | 30.0 | pF |

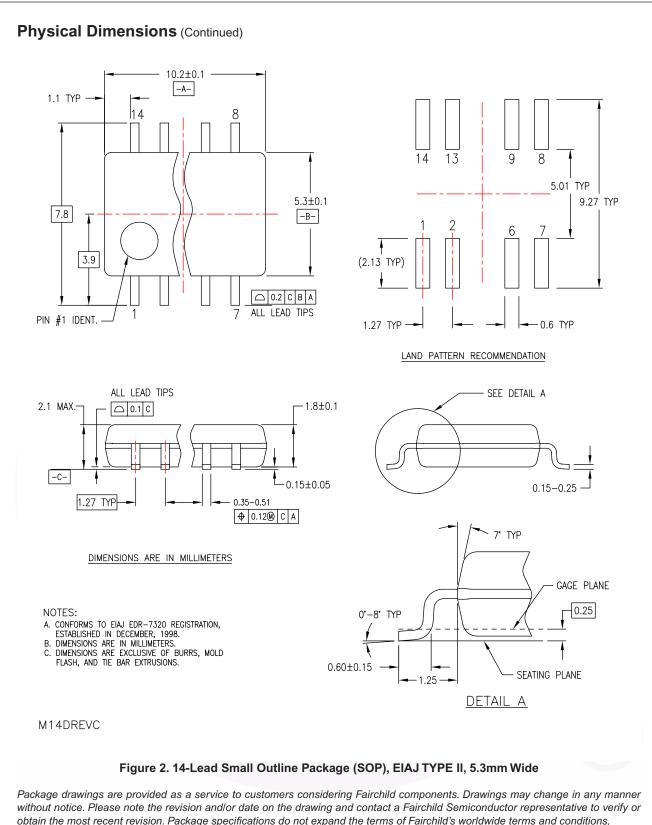


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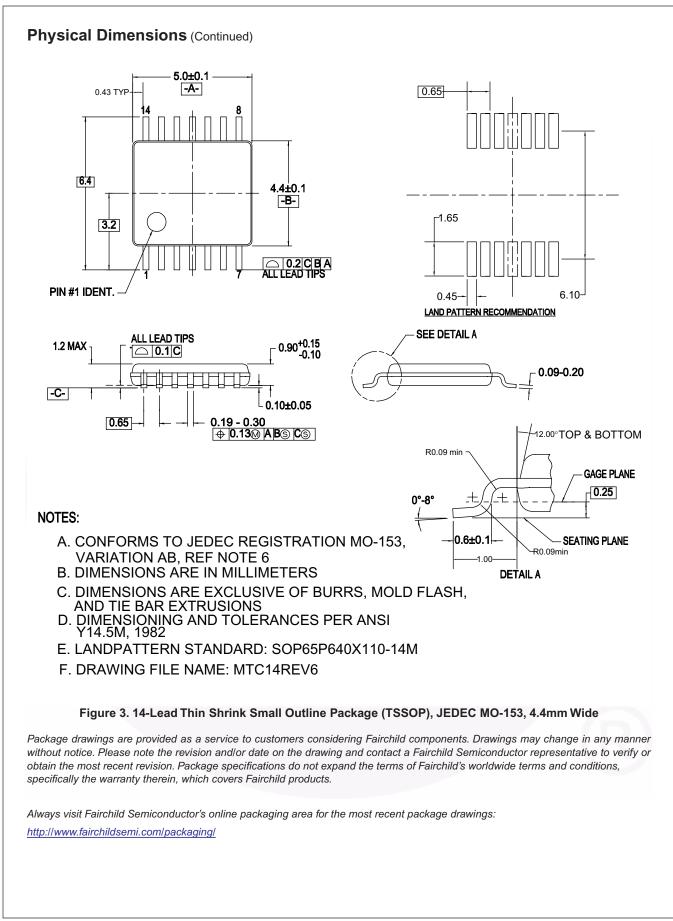


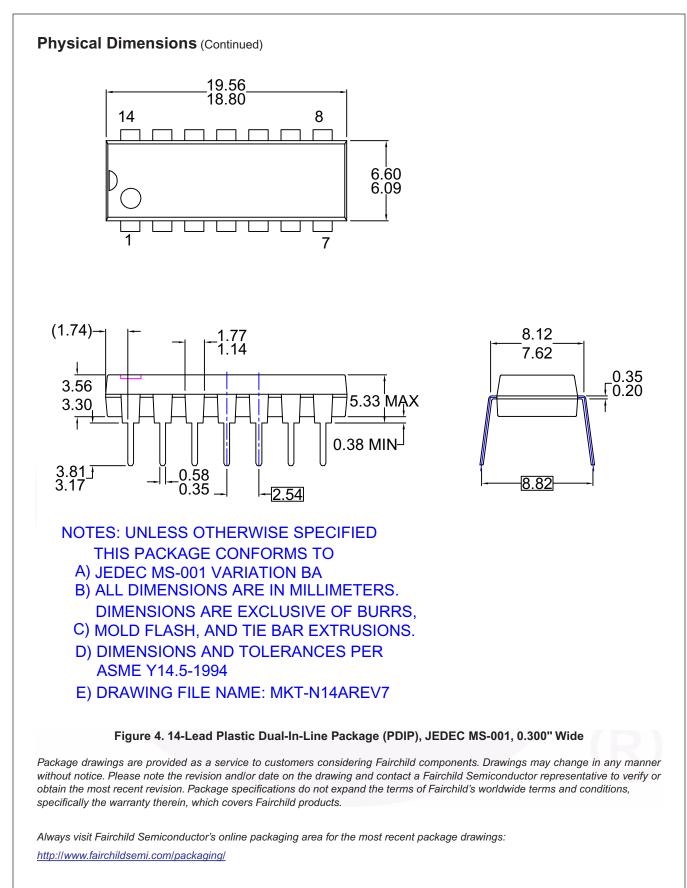


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